



**INTERNAL VISUAL INSPECTION
OF MONOLITHIC MICROWAVE INTEGRATED CIRCUITS**

ESCC Basic Specification No. 2049010

PLEASE REFER TO SPECIFICATION 2045010

Issue 2	July 2013
---------	-----------



Document Custodian: European Space Agency – see <https://escies.org>

LEGAL DISCLAIMER AND COPYRIGHT

European Space Agency, Copyright © 2013. All rights reserved.

The European Space Agency disclaims any liability or responsibility, to any person or entity, with respect to any loss or damage caused, or alleged to be caused, directly or indirectly by the use and application of this ESCC publication.

This publication, without the prior permission of the European Space Agency and provided that it is not used for a commercial purpose, may be:

- copied in whole, in any medium, without alteration or modification.
- copied in part, in any medium, provided that the ESCC document identification, comprising the ESCC symbol, document number and document issue, is removed.

DOCUMENTATION CHANGE NOTICE

(Refer to <https://escies.org> for ESCC DCR content)

DCR No.	CHANGE DESCRIPTION
799	Specification upissued to incorporate editorial changes per DCR.